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THz Generation by Optical Rectification and Competition

with Other Nonlinear Processes *

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We present a study of the competition between tera-hertz (THz) generation by optical

rectification in <110> ZnTe crystals, two-photon absorption, second harmonic

generation and free-carrier absorption. The two-photon nonlinear absorption

coefficient, second harmonic generation efficiency and free-carrier absorption

coefficient in the THz range are measured independently. The incident pump field is

shown to be depleted by two-photon absorption and the THz radiation is shown to be

reduced, upon focusing, by free-carrier absorption. The reduction of the generated

THz radiation upon tight focusing is explained, provided that one also takes into

account diffraction effects from the sub-wavelength THz source.

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Ultra-fast THz spectroscopy is a powerful technique for studying a wide variety of materials including gases, liquids and solids.[1] In this context, a now widely used technique consists in generating THz pulses by optical rectification of femtosecond laser pulses.[2-4] An ultra-fast optical pulse is focused on a nonlinear crystal, which then radiates a THz pulse with duration of few cycles of the electromagnetic field. In the spectral domain, the radiation is broadband, from about 100 GHz to typically 3 THz for a 100 fs pulse. For an excitation with a typical Ti:sapphire mode-locked laser, the generated THz power is in the range of only a few tens of nW, which stresses the importance of understanding and optimizing the THz generation in nonlinear crystals. Efficient optical rectification requires using materials with large second-order nonlinear susceptibilities and well-suited phase-matching properties for THz generation. ZnTe crystals with a <110> orientation offer one of the best compromises.[5,6] Unfortunately, when a ZnTe crystal is irradiated with a high-power laser pulse, other competing nonlinear processes such as second harmonic generation (SHG), two-photon absorption (TPA) and subsequent free-carriers absorption (FCA) may also occur, resulting in a decrease of the THz generation.[6-11] Additional competing mechanisms have also been put forward, such as the fact that upon focusing, the size of the THz source (the laser spot size) becomes smaller than the typical THz wavelength, resulting in a decrease of the THz generation due to diffraction.[10,12] Nevertheless, to date, existing analysis of this competition are not comprehensive and the explanations are sometimes even contradictory.[10,11] Moreover, the effect of free carrier absorption[13] of the THz radiation (in this

context) was neglected in previous studies.

In the present work, we investigate the THz generation by optical rectification in a <110> 10×10×2 mm ZnTe crystal as a function of power, focusing and crystal orientation. The conditions for the most efficient THz generation are described. Upon focusing, for excitation sizes smaller that the THz wavelength, SHG, TPA as well as FCA is observed while the THz emission is strongly reduced. While TPA is responsible for the optical pump depletion, we find that FCA of the THz radiation cannot be neglected, as often assumed in the past. Both contributions are found to be of the same order of magnitude.

The excitation of the <110> 2-mm-thick crystal was provided by a 800 nm Ti:sapphire laser (100 fs pulses) at 300 mW, using a 4-cm focusing lens. The ZnTe crystal is virtually transparent in the frequency domain of interest.[9] The detection of the THz radiation was performed by a liquid helium cooled bolometer.

First, in order to characterize their efficiency, we measured the TPA and SHG as a function of the crystal azimuthal angle and distance from focus point. Figure 1 shows the THz emission (spectrally integrated) as a function of the ZnTe azimuthal angle (closed symbols). The THz intensity is proportional to the square of the nonlinear polarization, in which angle dependence (angle between the polarization of the optical pump beam and the [001] axis) is determined by the nonlinear susceptibility tensor.[14] Figure 1 also shows the angle dependence of the measured SHG (open symbols) and of the transmission at 800 nm when the crystal is placed at the laser beam waist. In principle, optical rectification, SHG as well as TPA can be responsible

for the optical pump depletion. Nevertheless, the optical rectification efficiency is only on the order of 10⁻⁷, as already pointed out in previous studies,[11] SHG generation is also inefficient in depleting the pump, and the variations observed in transmission can only be attributed to TPA. We note that easy crystal axis determination is highly desirable when developing ultra-fast THz spectroscopy experiments based on optical rectification and free-space electro-optical sampling. In this case, several parameters need to be properly adjusted simultaneously (crystals orientation, pump focusing, time delay, spot overlap). In this context, Fig. 1 also shows that measuring the angle-dependence of the transmission is the simplest method for determining the best crystal orientation for optimum THz generation.

Competition between the nonlinearities was investigated using a open-aperture z-scan method.[11,15,16] The THz emission, SHG and transmission at 800 nm measured as a function of the distance z between the beam waist and the crystal, along the optical axis (with an azimuthal angle corresponding to a maximum of THz emission). As shown in Fig. 2(a), upon focusing, the THz emission first increases. For z < 10 mm, the THz emission tends to saturate. For even smaller distances, the THz emission drops significantly, forming a z-hole, as already reported. As a consequence, it is now well accepted that the optimum THz generation is obtained when the crystal is placed slightly out of focus. We note that, as shown by Dakovski $et\ al.$,[10] this z-hole does not depend on the THz wavelength (so the fact that the emission is spectrally integrated does not play a significant role here). Figure 2(b) shows the measured SHG power and transmission at 800 nm as a function of distance from

focus. TPA is responsible for the depletion of the optical pump intensity following $dI/dz = -\beta I^2$, where β is the nonlinear absorption coefficient (the linear absorption is neglected). The integration of this equation leads to the z-dependence of the transmitted power $P_t = I \times S(z) = P_0/(1 + \beta P_0 S(z)^{-1}l)$, where l is the crystal thickness and S(z) the spot surface (gaussian beam). Figure 2(b) shows a fit of the transmission data giving a nonlinear absorption coefficient $\beta = 4.6$ cm/GW due to TPA, in good agreement with the previous studies.[10,11,15,16]. Likewise, the SHG power is inversely proportional to the surface (Fig. 2(b)).

In order to estimate the free-carrier absorption of the THz radiation, we performed a two-colour experiment as depicted in Fig. 3: The ZnTe crystal is placed at z=15 mm away from the focus, where optical rectification is not in competition with other nonlinearities. A BBO crystal is placed between the focusing lens and the ZnTe crystal. The THz radiation intensity generated by the 800 nm pump beam is measured when the blue-beam (400 nm) power is varied from 0 mW (I_{THz}^1) to 1 mW (I_{THz}^2) by adjusting the BBO azimuthal angle. This allows extracting a free-carrier absorption coefficient $\alpha_{THz} = I^{-1} \ln(I_{THz}^1/I_{THz}^2) = 6 \text{ cm}^{-1}$. This two-colour experiment allows estimating the effect of the free-carrier absorption on the THz radiation within experimental conditions as close as possible to what occurs when focusing the pump beam (i.e. when free carriers can be generated). In this case, hot free-carriers (electron and holes) are generated simultaneously with generation of the THz radiation (i.e. zero time-delay), resulting in absorption of the THz radiation.[8,13]

In the following, we first discuss the THz emission z-dependence induced by

diffraction effects. When z is large compared to the pump beam Rayleigh length, the spot surface S is proportional to z^2 . As pointed out in Refs. [10,12], since optical rectification is a second-order nonlinear process, the nonlinear polarization is proportional to the optical intensity $I_0 = P_0/S$. When diffraction effects can be neglected (spot size larger than the typical THz wavelength, 300 µm), the THz power is $P_{THz} \propto S(P_0/S)^2 \propto z^{-2}$, as observed experimentally and depicted in Fig. 4. On the contrary, when the pump size is smaller than the THz wavelength, the THz emission from the whole emitter section interfere constructively and the THz emitted power reads[6] $P_{THz} \propto (S(P_0/S))^2 \propto z^0$ and the THz power becomes independent of the spot size close to focus. This is sketched by the solid horizontal line in Fig. 4. Next, as shown above the THz radiation is partly reduced by FCA. Free carriers can be generated either by SHG or TPA in the ZnTe crystal. The free carrier generation rate by TPA is given by $\beta I_{800nm}^2 / 2 \hbar \omega$, whereas the free carrier generation rate by SHG is αI_{400nm} / $\hbar\omega$, where α is the absorption coefficient at 400 nm (33 cm⁻¹).[11] As a result, the TPA over SHG free carrier generation rate ratio is 0.35. In this context, the equation describing the THz generation has the form $dE_{THz}/dz = aE_0^2 - \alpha_{THz}E_{THz}$, where the first term is due to optical rectification and the second to the free-carrier absorption. The THz electric field then varies as $E_{THz} = \eta \times aE_0^2 l$, where $\eta = (1 - e^{-\alpha_{THz}l})/\alpha_{THz}l$ is a factor that reduces the THz field induced by optical rectification. If we first assume that the absorption coefficient $\alpha_{{\scriptscriptstyle T\!H\!z}}$ is proportional to the free-carrier density and thus inversely proportional to the pump spot surface, one can estimate the z-dependence of the THz radiation power in the presence of FCA

(dotted line in Fig. 4). Nevertheless, when focusing, the pump surface becomes considerably smaller than the THz spot size. Thus, the dotted line in Fig. 4 tends to overestimate the effect of FCA. As an upper bound, one can alternatively consider that the absorption of THz becomes surface-independent in the diffraction limit, which underestimates FCA (dashed line). Lastly, as shown above, TPA is responsible for the depletion of the pump beam and, in the diffraction limit, this leads to a THz power $P_{THz} \propto P_0^2/(1+\beta P_0 S(z)^{-1} l)^2$, which is partly responsible for the formation of a z-hole close to focus. This is shown by the thick solid line in Fig. 4, where, for sake of clarity, the effect of the pump depletion by TPA on the THz emission was estimated independently of FCA.

In conclusion, we have studied the competition between THz generation by optical rectification, optical pump depletion by TPA and THz free-carrier absorption. We have shown that both TPA and free-carrier absorption strongly contribute to the reduction of the THz generation upon tight focusing.

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Figures Caption

- Fig. 1. Closed squares: THz intensity as a function of the ZnTe azimuthal angle.

 Open circles: SHG intensity upon focusing. Open squares: transmission at 800 nm.
- Fig. 2. (a) THz intensity as a function of the distance to focus point (open aperture z-scan). Pump power 300 mW. (b) Circles: SHG power. Squares: transmission at 800 nm. Solid line, right axis: fit of the TPA equation (nonlinear absorption coefficient □ = 4.6 cm/GW). Solid line, left axis: fit of the SHG.
- Fig. 3. Scheme of the two-colour experiment. The ZnTe crystal is placed at z=15 mm away from the focus. A BBO crystal is placed between the focusing lens and the ZnTe crystal. The THz radiation intensity generated by the 800 nm pump beam is measured as a function of the blue-beam power generated by the BBO crystal.
- Fig. 4. Circles: measured THz intensity. Dot-dot-dashed line: expected THz emission z-dependence for large z, when the THz source is larger than the typical THz wavelength. Horizontal solid line: expected THz emission z-dependence in the diffraction limit (small excitation spot size). Solid curve: THz emission z-dependence including TPA only. Dashed line: THz emission z-dependence including FCA only, when the absorption coefficient is assumed to be independent of size. Dotted line: THz emission z-dependence including FCA only, when the absorption coefficient is assumed to be inversely proportional to the pump spot size.

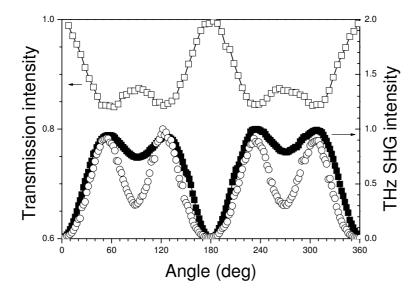


Fig. 1.

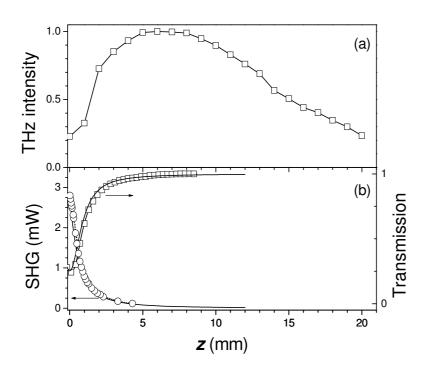


Fig. 2.

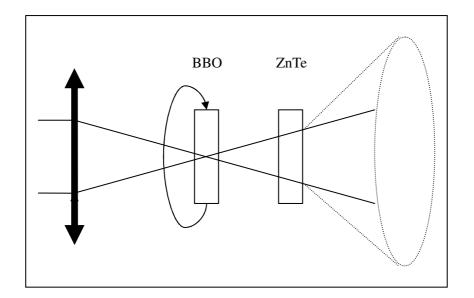


Fig. 3.

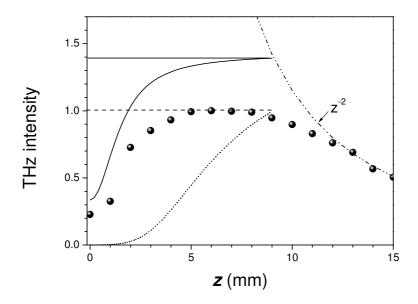


Fig. 4.